Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/774,169	BAR ET AL.	
Examiner	Art Unit	
Thuong (Tina) T. Nguyen	2155	

	SEARCHED		
Class	Subclass	Date	Examiner
709	218, 223, 224,225	4/9/2006	тн
713	152,166	4/9/2006	тн
		,	

TNI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
-			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	
IEEE	4/9/200	06 TH
EAST	4/9/200	06 TH